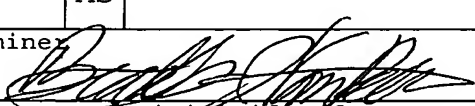


FORM PTO-1449				Atty. Docket No. XA-9620		Appln. No. #3	
<u>LIST OF DOCUMENTS CITED BY APPLICANT</u>				Applicant CHIKARAISHI, Kazuo et al.			
				Filing Date HEREWITH		Group 3682	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
BA	AA	5,445,238	08/29/95	Chikuma et al. (corresps. to Doc AG)	180	79.1	
	AB						
	AC						
	AD						
	AE						
	AF						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
BA	AG	7-215227	08/15/95	Japan			No
	AH	11-139326	05/25/99	Japan			No
	AI	7-223548	08/22/95	Japan			No
	AJ	11-29052	02/02/99	Japan			No
	AK	10-220560	08/21/98	Japan			No
	AL	7-119810	05/12/95	Japan			No
	AM	58-35040	03/07/83	Japan			No
	AN	0 915 004	05/12/99	Europe			
✓	AO	0 666 210	08/09/95	Europe			
OTHER (including author, title, date, pertinent pages, etc.)							
	AQ						
	AR						
	AS						
Examiner 				Date Considered 4/15/03			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							

FORM PTO-1449

Atty. Docket No.

Appln. No.

XA-9620

10/049,602

LIST OF DOCUMENTS CITED BY APPLICANT

Applicant

Kazuo CHIKARAISHI et al.

Filing Date

February 14, 2002

Group

3618 3682

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date
AA						
AB						
AC						
AD						
AE						
AF						

RECEIVED

MAY 16 2002

GROUP 3000

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Sub-class	Translation
AG	UM 2556890	08/22/97	Japan			No
AH	11-192955	07/21/99	Japan			Abstract
AI	8-80858	03/26/96	Japan			Abstract
AJ	9-20256	01/21/97	Japan			Abstract
AK	10-100912	04/21/98	Japan			Abstract
AL	10-329732	12/15/98	Japan			Abstract
AM						

OTHER (including author, title, date, pertinent pages, etc.)

AN	
AO	
AP	

Examiner

Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.